

Designation: E 376 - 03

Standard Practice for Measuring Coating Thickness by Magnetic-Field or Eddy-Current (Electromagnetic) Examination Methods¹

This standard is issued under the fixed designation E 376; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reapproval.

This standard has been approved for use by agencies of the Department of Defense.

1. Scope

- 1.1 This practice covers the use of magnetic- and eddycurrent-type thickness instruments (gages) for nondestructive thickness measurement of a coating on a metal substrate.
- 1.2 More specific uses of these instruments are covered by the following test methods issued by ASTM: Test Methods B 244, B 499, B 530, D 1186, D 1400, and G 12.
- 1.3 The values stated in SI units are to be regarded as standard. The inch-pound units in parentheses are for information only and may be approximate.
- 1.4 Measurements made in accordance with this practice will be in compliance with the requirements of ISO International Standard 2178 as printed in 1982.
- 1.5 This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.

2. Referenced Documents

- 2.1 ASTM Standards:
- B 244 Test Method for Measurement of Thickness of Anodic Coatings on Aluminum and of Other Nonconductive Coatings on Nonmagnetic Basis Metals with Eddy-Current Instruments²
- B 499 Test Method for Measurement of Coating Thicknesses by the Magnetic Method: Nonmagnetic Coatings on Magnetic Basis Metals²
- B 530 Test Method for Measurement of Coating Thicknesses by the Magnetic Method: Electrodeposited Nickel Coatings on Magnetic and Nonmagnetic Substrates²
- D 1186 Test Methods for Nondestructive Measurement of Dry Film Thickness of Nonmagnetic Coatings Applied to a Ferrous Base³

- D 1400 Test Method for Nondestructive Measurement of Dry Film Thickness of Nonconductive Coatings Applied to a Nonferrous Metal Base³
- E 1316 Terminology for Nondestructive Examinations⁴
- E 543 Practice for Agencies Performing Nondestructive Testing⁴
- G 12 Test Method for Nondestructive Measurement of Film Thickness of Pipeline Coatings on Steel⁵
- 2.2 ASNT Standards:⁶
- SNT-TC-1A Recommended Practice for Personnel Qualification and Certification in Nondestructive Testing
- ANSI/ASNT-CP-189 Standard for Qualification and Certification of NDT Personnel
- 2.3 AIA Standard:
- NAS 410 Certification and Qualification of Nondestructive Testing Personnel⁷
- 2.4 International Standard:
- ISO 2178 Nonmagnetic Coatings on Magnetic Substrate— Measurement of Coating Thickness—Magnetic Method⁸

Note 1—See Appendix X1. 2ae850146/astm-e376-03

3. Terminology

3.1 *Definitions*—Definitions of terms relating to electromagnetic examination are given in Terminology E 1316.

4. Significance and Use

- 4.1 *General*—No presently available thickness gage is applicable to all combinations of coating-substrate thicknesses and materials. The limitations of a particular instrument are generally delineated by its manufacturer.
- 4.2 *Magnetic*—Magnetic-type gages measure either magnetic attraction between a magnet and a coating or its substrate,

¹ This practice is under the jurisdiction of ASTM Committee E07 on Nondestructive Testing and is the direct responsibility of Subcommittee E07.07 on Electromagnetic Method.

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² Annual Book of ASTM Standards, Vol 02.05.

³ Annual Book of ASTM Standards, Vol 06.01.

⁴ Annual Book of ASTM Standards, Vol 03.03.

⁵ Annual Book of ASTM Standards, Vol 06.02.

⁶ Available from The American Society for Nondestructive Testing (ASNT), P.O. Box 28518, 1711 Arlingate Ln., Columbus, OH 43228-0518.

⁷ Available from Aerospace Industries Association of America, Inc., 1250 Eye St., NW, Washington, DC 20005. (Replacement standard for MIL-STD-410.)

⁸ Available from American National Standards Institute (ANSI), 25 W. 43rd St., 4th Floor, New York, NY 10036.

or reluctance of a magnetic flux path passing through the coating and substrate. These gages are designed to measure thickness of a nonmagnetic coating on a magnetic substrate. Some of them will also measure thickness of nickel coatings on a magnetic or nonmagnetic substrate.

4.3 Eddy Current—Eddy-current-type thickness gages are electronic instruments that measure variations in impedance of an eddy-current inducing coil caused by coating thickness variations. They can only be used if the electrical conductivity of the coating differs significantly from that of the substrate.

5. Interferences

- 5.1 *Thickness of Coating*—The precision of a measurement changes with coating thickness depending on method used and instrument design. Generally, the precision is a percentage of the coating thickness except at the lower end of the ranges where it is a fixed thickness.
- 5.2 Magnetic Properties of Basis Metal—Magnetic thickness gages are affected by variations of the magnetic properties of the basis metal. For practical purposes, magnetic variations in low-carbon AISI 1005-1020 steels may be considered to be insignificant. To avoid the influences of severe or localized heat treatments and cold working, the instrument should be standardized using a reference standard having a base metal with the same magnetic properties as that of the test specimen or, preferably and if available, with a sample of the part to be examined before application of the coating.
- 5.3 Thickness of Substrate—For each method there is an effective depth of penetration of field created by the instrument probe. This is the critical depth or thickness beyond which the instrument will no longer be affected by increase of substrate thickness. Since it depends on the instrument probe and substrate, it should be determined experimentally.
- 5.4 Structure and Composition of Coating and Substrate—Eddy-current instruments are sensitive to variations of structure, composition, and other factors affecting electrical conductivity and magnetic permeability of the coating and substrate. For example, such instruments are sensitive to differences between: (1) aluminum alloys, (2) chromium coatings deposited at different temperatures, and (3) organic coatings containing variable amounts of metallic pigments.
- 5.5 Edge Effect—All examination methods are sensitive to abrupt surface changes of test specimens; therefore, measurements made too near an edge or inside corner will not be valid unless the instrument is specifically standardized for such a measurement. The effect usually extends 3 to 13 mm [1/8 to 1/2 in.] from the discontinuity, depending on method probe configuration, and instrument. Edge effect is usually a function of coil diameter.
- 5.6 Curvature of Examination Surface—Thickness measurements are sensitive to curvature of the specimen. This sensitivity varies considerably between instruments and becomes more pronounced with increasing curvature.
- 5.7 Smoothness of Surface, Including That of Base Metal—Since a rough surface may make single measurements inaccu-
- ⁹ Autocatalytically deposited nickel-phosphorus alloys containing more than 8 % phosphorus are sufficiently nonmagnetic to be measured by this method, as long as the measurement is made prior to any heat treatment.

- rate, a greater number of measurements will provide an average value that is more truly representative of the overall coating thickness. Roughness also may cause certain instruments to read high since their probes may rest on peaks.
- 5.8 Direction of Rolling of Base Metal—Instruments with two pole pieces may be sensitive to direction of rolling of the base metal; that is, gage readings may change depending on alignment of pole pieces with surface of specimen or part under examination.
- 5.9 Residual Magnetism in Base Metal—Residual magnetism in base metal may affect readings of magnetic- and eddy-current-type instruments.
- 5.10 *Stray Magnetic Fields*—Strong magnetic fields, as from arc welding, can seriously interfere with operations of certain thickness gages.
- 5.11 Cleanness of Probe and Test Surface—Measurements are sensitive to foreign material that prevents intimate contact between probe and coating surface.
- 5.12 *Pressure of Probe*—Instrument readings can be sensitive to pressure with which probe is applied to test surface.
- 5.13 *Probe Position*—Some magnetic-type gages are sensitive to position of probe relative to the earth. For example, operation of gage in a horizontal or upside-down position may require a new standardization or may be impossible.
- 5.14 *Temperature*—Eddy-current instruments may be affected by temperature variations.

6. Basis of Application

- 6.1 The following items are subject to contractual agreement between the parties using or referencing this standard.
- 6.2 Personnel Qualification
- 6.2.1 If specified in the contractual agreement, personnel performing examinations to this standard shall be qualified in accordance with a nationally or internationally recognized NDT personnel qualification practice or standard such as ANSI/ASNT-CP 189, SNT-TC-1A, NAS-410, or a similar document and certified by the employer or certifying agency, as applicable. The practice or standard used and its applicable revision shall be identified in the contractual agreement between the using parties.
- 6.3 Qualification of Nondestructive Testing Agencies—If specified in the contractual agreement, NDT agencies shall be qualified and evaluated as described in Practice E 543. The applicable edition of E 543 shall be specified in the contractual agreement.
- 6.4 *Procedures and Techniques*—The procedures and techniques to be utilized shall be as specified in the contractual agreement.
- 6.5 Surface Preparation—The pre-examination surface preparation criteria shall be in accordance with 5.11 and requirements specified in the contractual agreement.
- 6.6 *Timing of Examination*—The timing of examination shall be in accordance with the applicable contractual agreement.
- 6.7 Extent of Examination—The extent of examination shall be in accordance with the applicable contractual agreement.
- 6.8 Reporting Criteria/Acceptance Criteria—Reporting criteria for the examination results shall be in accordance with Section 9 unless otherwise specified. Since acceptance criteria